



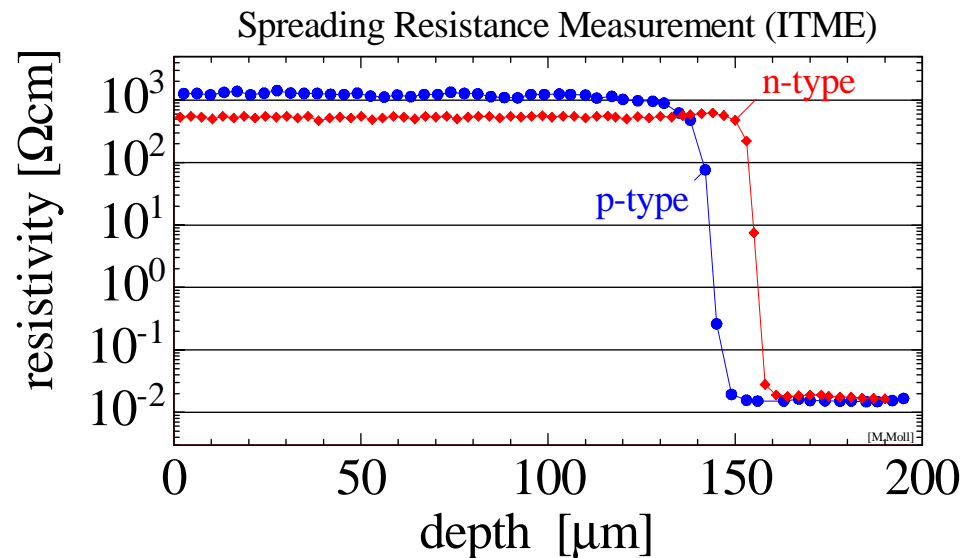
Epitaxial silicon detectors irradiated with protons and neutrons

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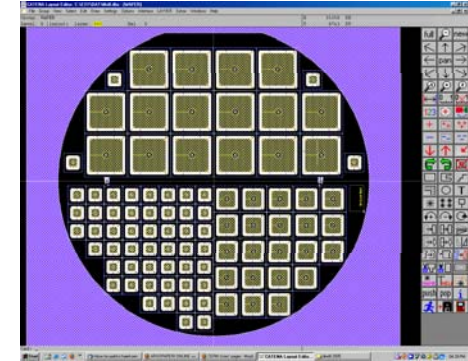
- **Produced by ITME** (Institute of Electronic Materials Technology, Warszawa, Poland)
 - 100 mm wafer
- **n-type silicon**
 - Epi-layer: 150 μm , <111>, P-doped, $\sim 500 \Omega\text{cm}$
 - Substrate: 525 μm , <111>, Sb-doped, $0.015 \Omega\text{cm}$
- **p-type silicon**
 - Epi-layer: 150 μm , <111>, P-doped, $\sim 1000 \Omega\text{cm}$
 - Substrate: 525 μm , <111>, B-doped, $0.015 \Omega\text{cm}$





- **HIP-004-C**

- Produced by Helsinki Institute of Physics, Helsinki, Finland
- Size 0.25 x 0.25 cm², thickness 150 μm
- n-type
- Depletion voltage (CV) before irradiation:
 $V_{dep} = 147.4 \pm 3.6 \text{ V}$

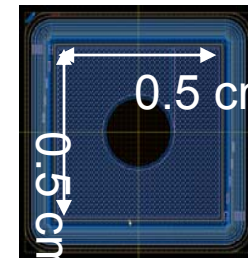


- **CNM-11**

- Produced by Centro Nacional de Microelectronics, Barcelona, Spain
- Size 0.5 x 0.5 cm², thickness 150 μm
- n-type
- Depletion voltage (CV) before irradiation:
 $V_{dep} = 154.6 \pm 7.5 \text{ V}$

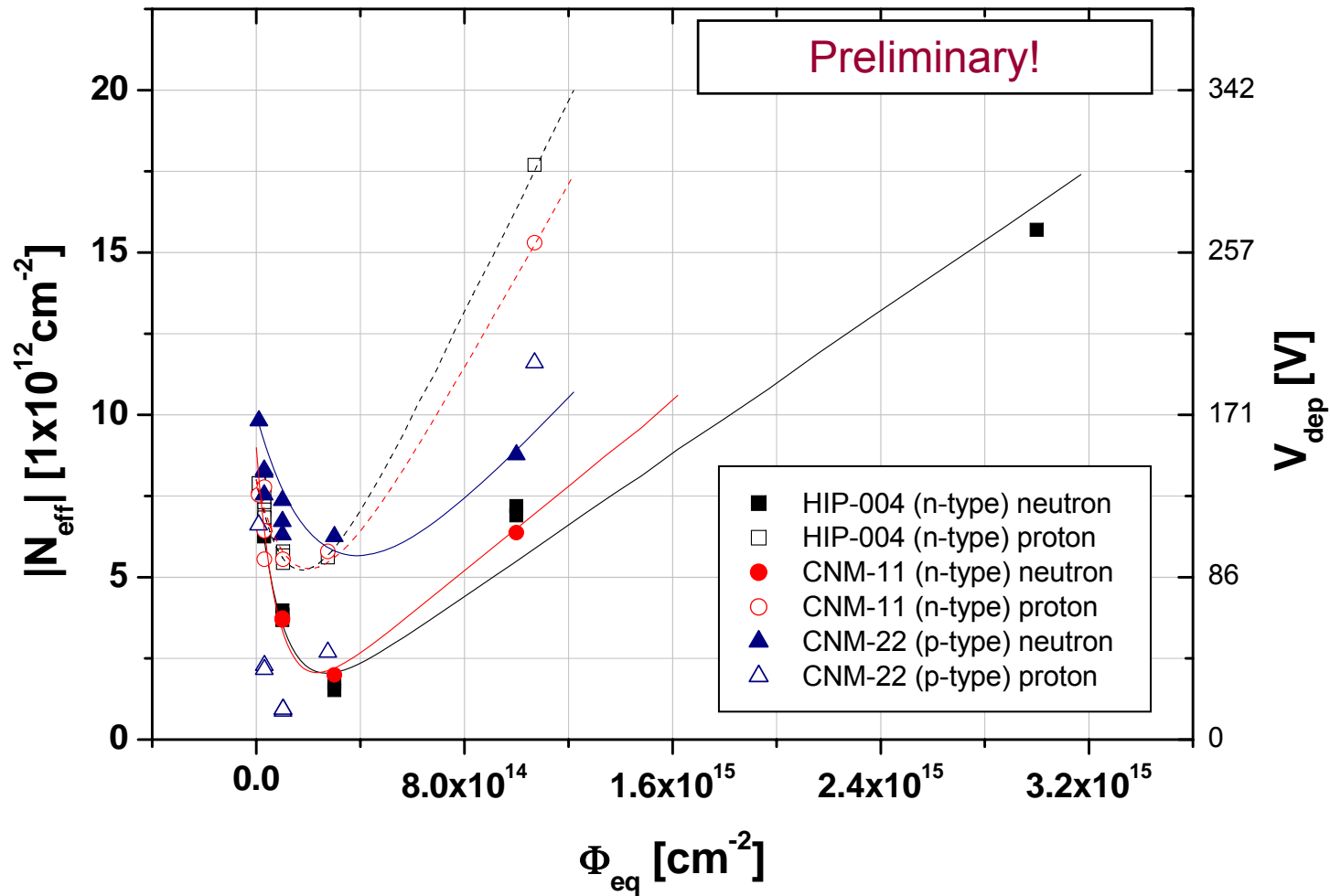
- **CNM-22**

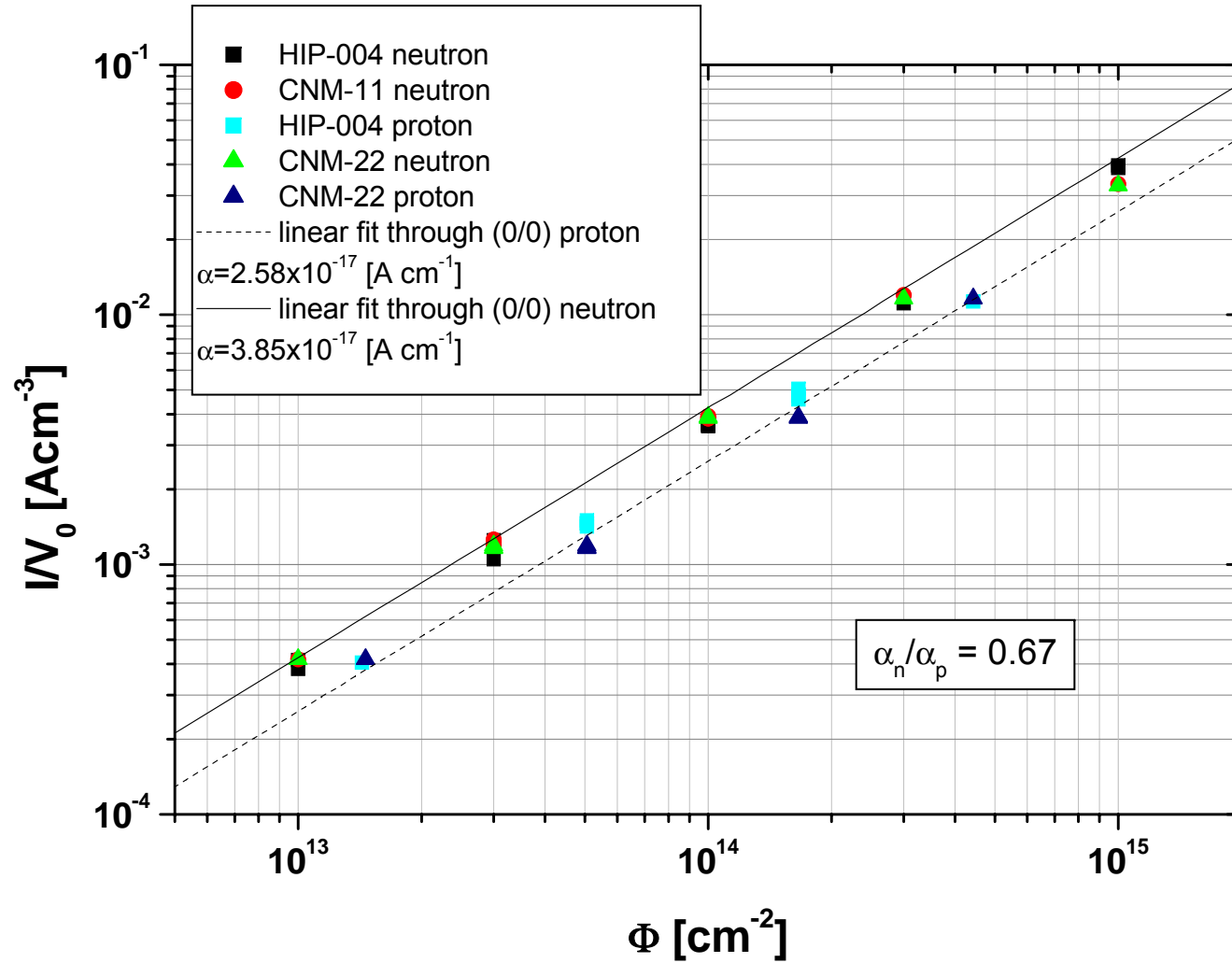
- Size 0.5 x 0.5 cm², thickness 150 μm
- p-type
- Depletion voltage (CV) before irradiation:
 $V_{dep} = 213.7 \pm 12.7 \text{ V}$

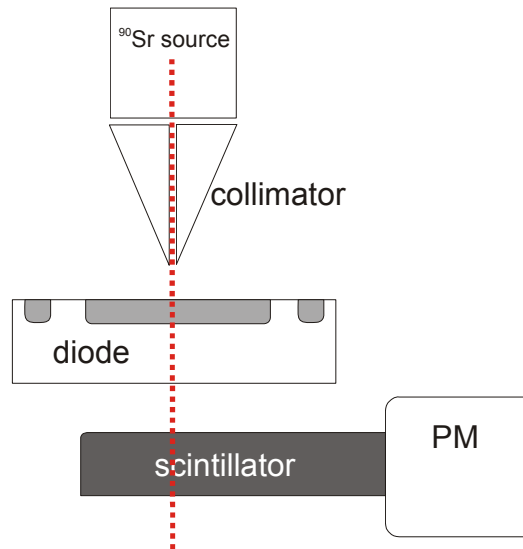




- **Irradiation**
 - 1 MeV neutrons in Ljubljana
 - 24 GeV/c protons at CERN
- **Annealing**
 - 4 minutes at 80°C
- **CV/IV**
 - Measured at room temperature in parallel mode at 10kHz
- **CCE**
 - NIKHEF setup







NIKHEF setup by Fred Hartjes

signal shaping time: 2.5 μs

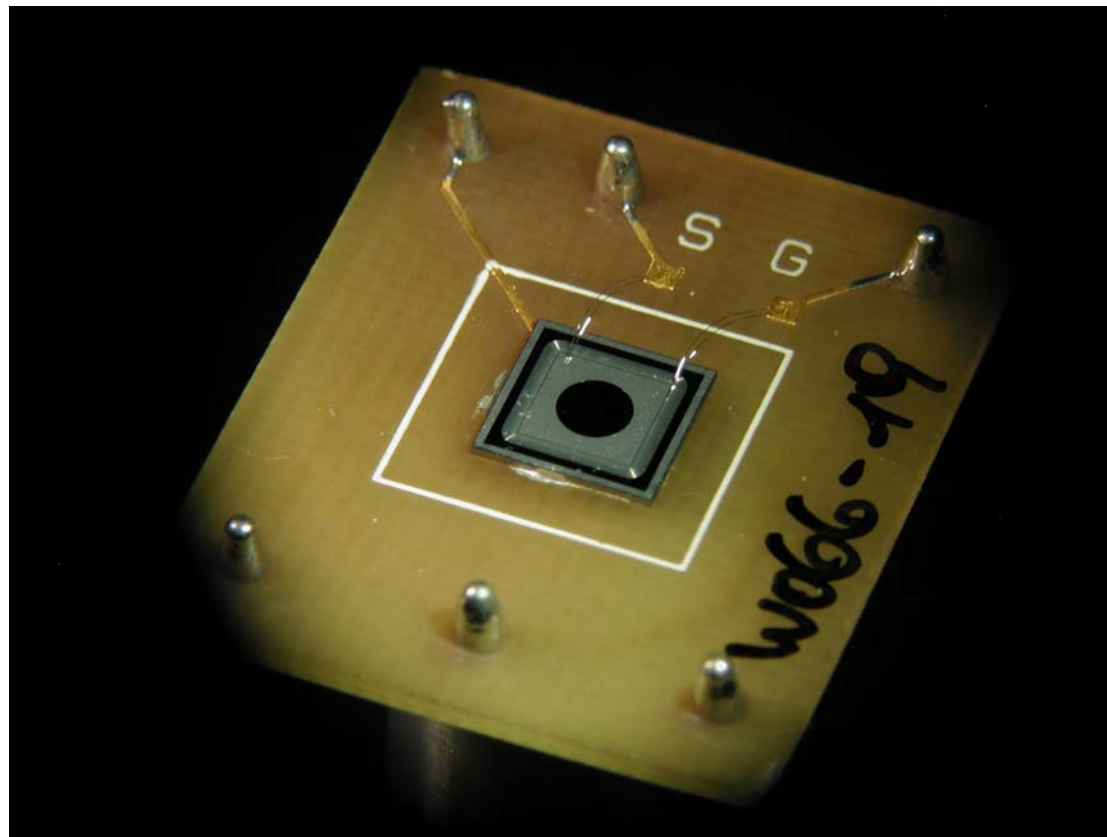
guard ring connected to ground

Temperature control:

- internal cooling with peltier
- whole box can be put into freezer

Temperature measurement:

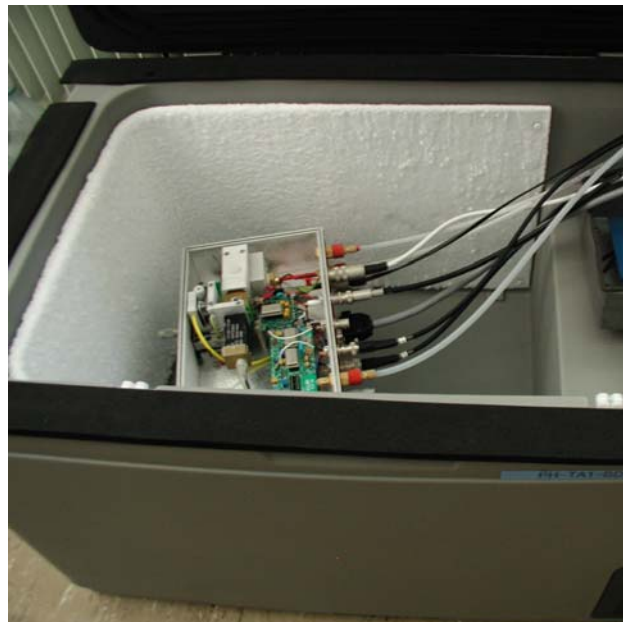
- directly on sample board
- in box with additional humidity sensor



- Detector glued on board with silver glue
- Guard ring connected to ground



- all detectors were measured at $-20 \pm 1^\circ\text{C}$ (only external cooling)
- humidity in the box was 18-30% (flushed with dry nitrogen)
- Repeated gain measurements showed a gain of $247 \text{ e}^-/\text{mV}$ for these conditions



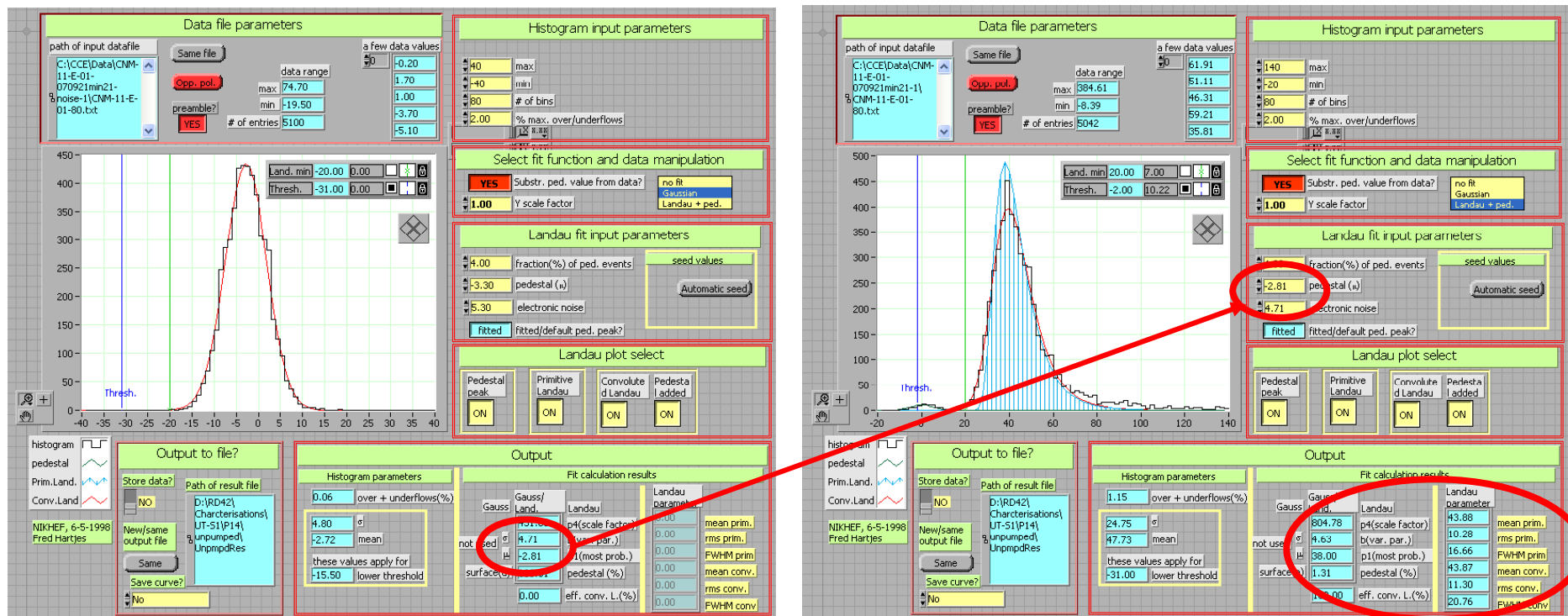


Example: CNM-11-01 (n-type)

irradiation: $\Phi = 1 \times 10^{14}$ p/cm²

temperature: -21 °C

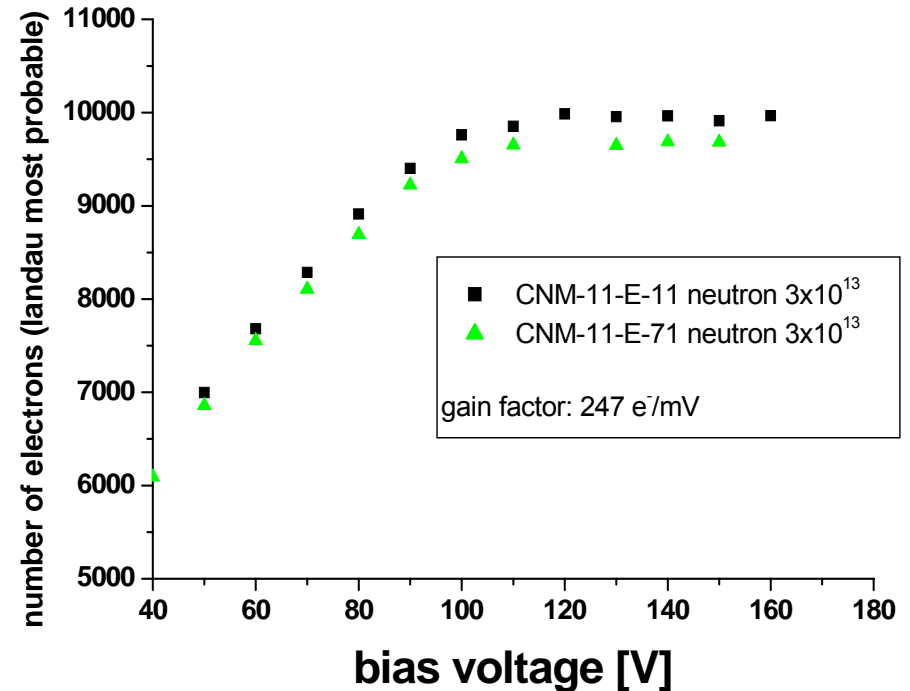
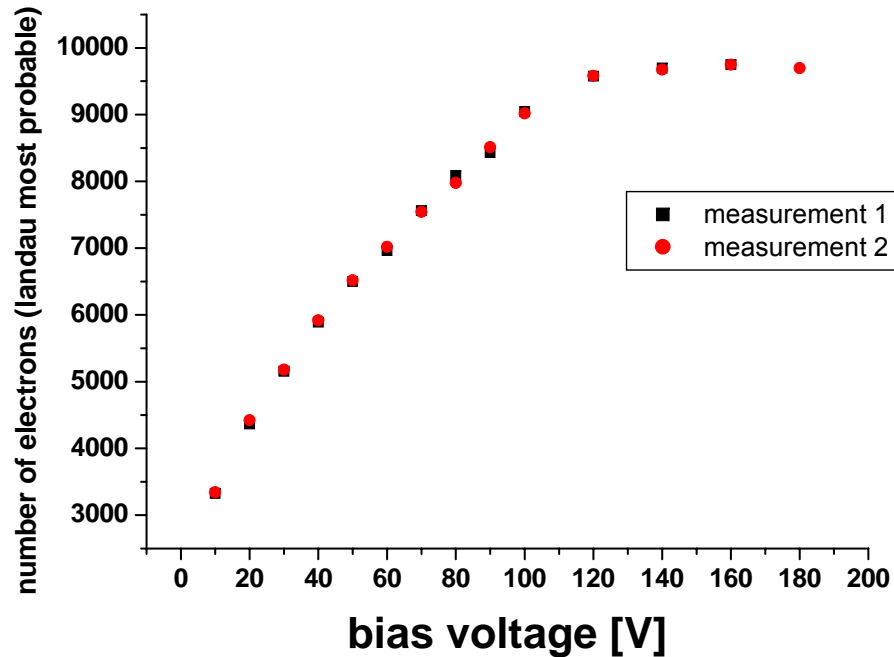
bias: 80 V



Noise/pedestal measurement for each bias point => values used for deconvoluted landau distribution

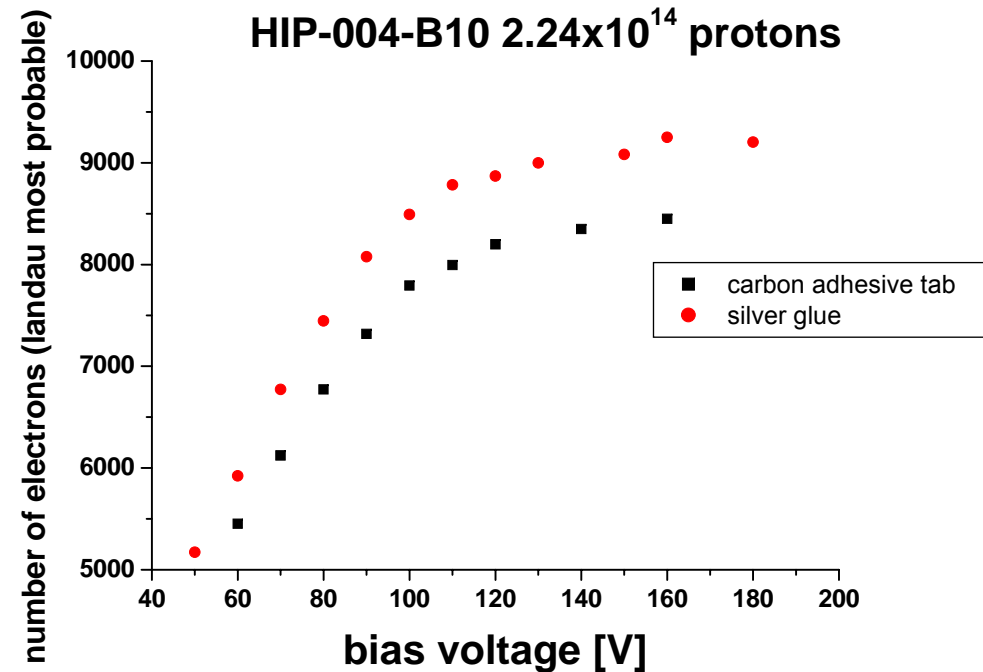
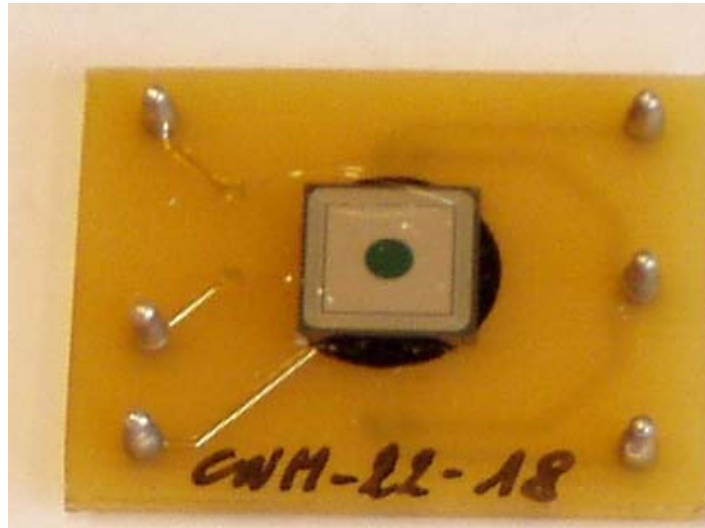


CNM-11-E-79 (n-type) 1×10^{13} neutrons

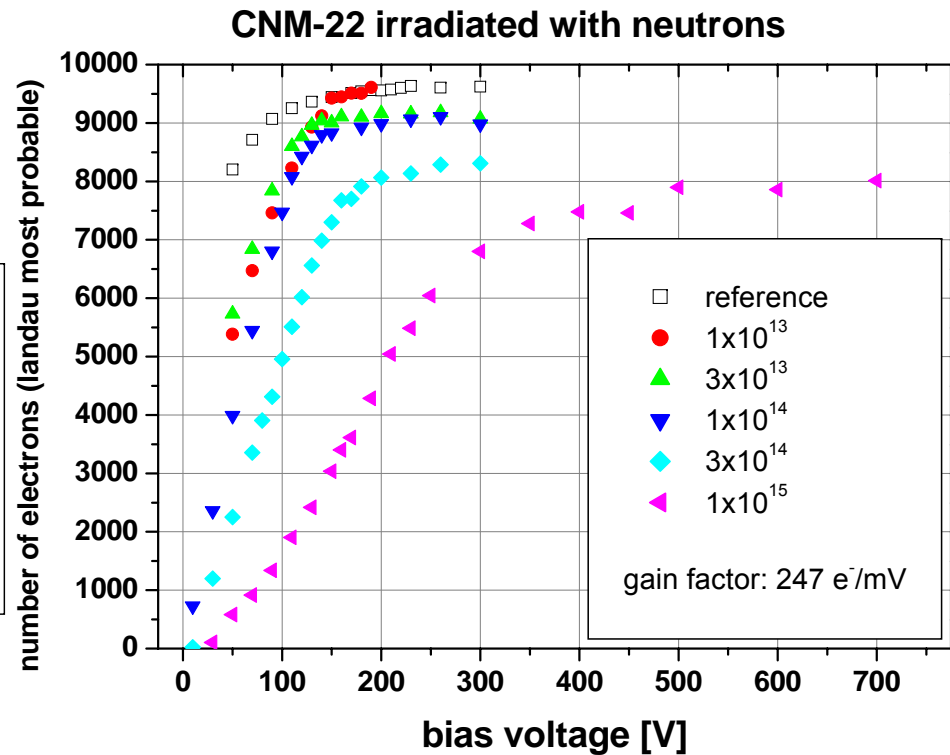
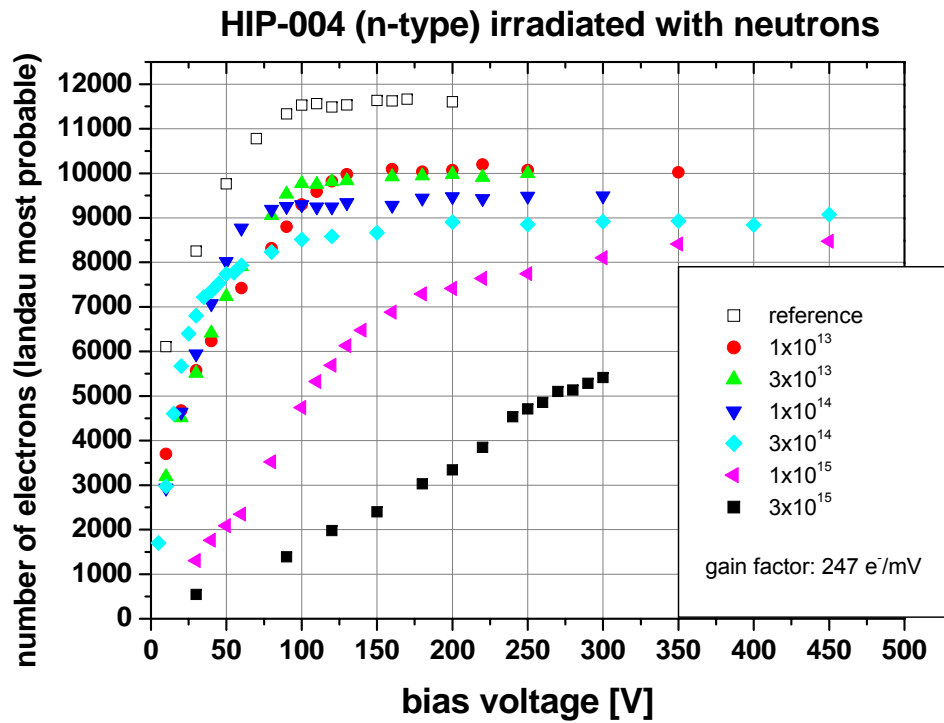


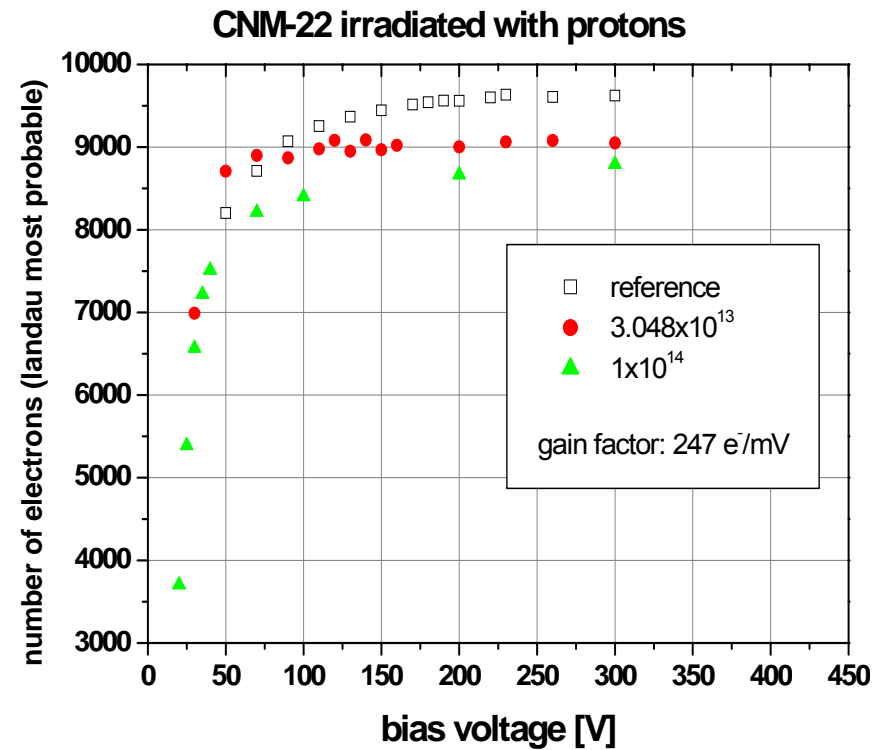
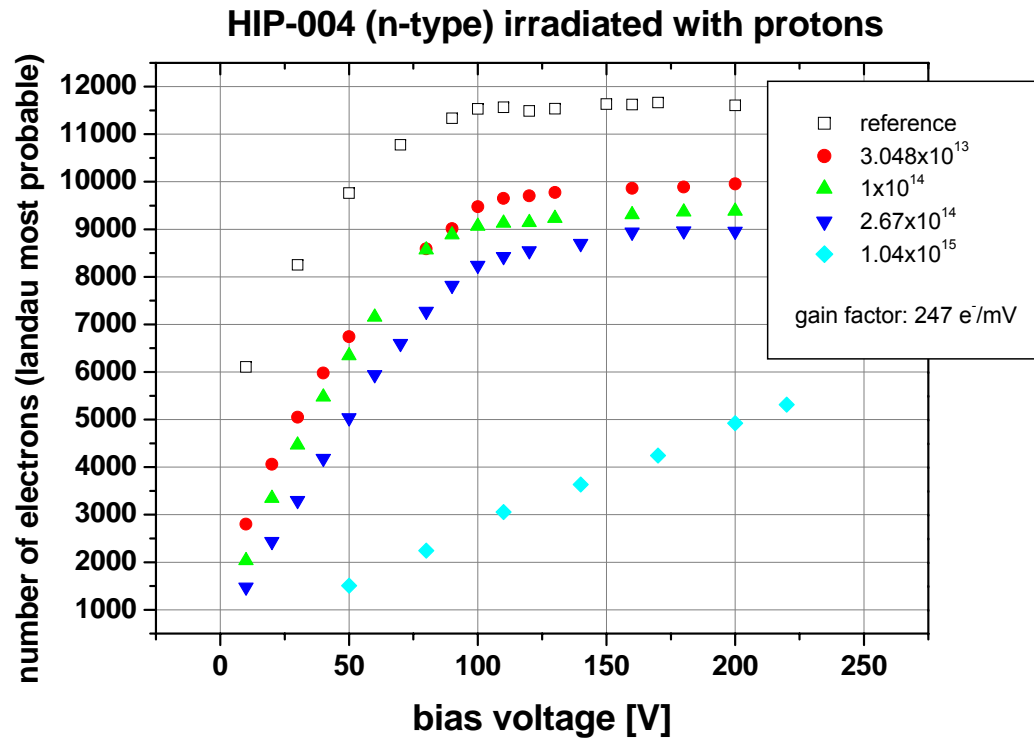
- Detector was **taken out** of the setup and remounted between measurements
- Temperature and humidity were approximately the same

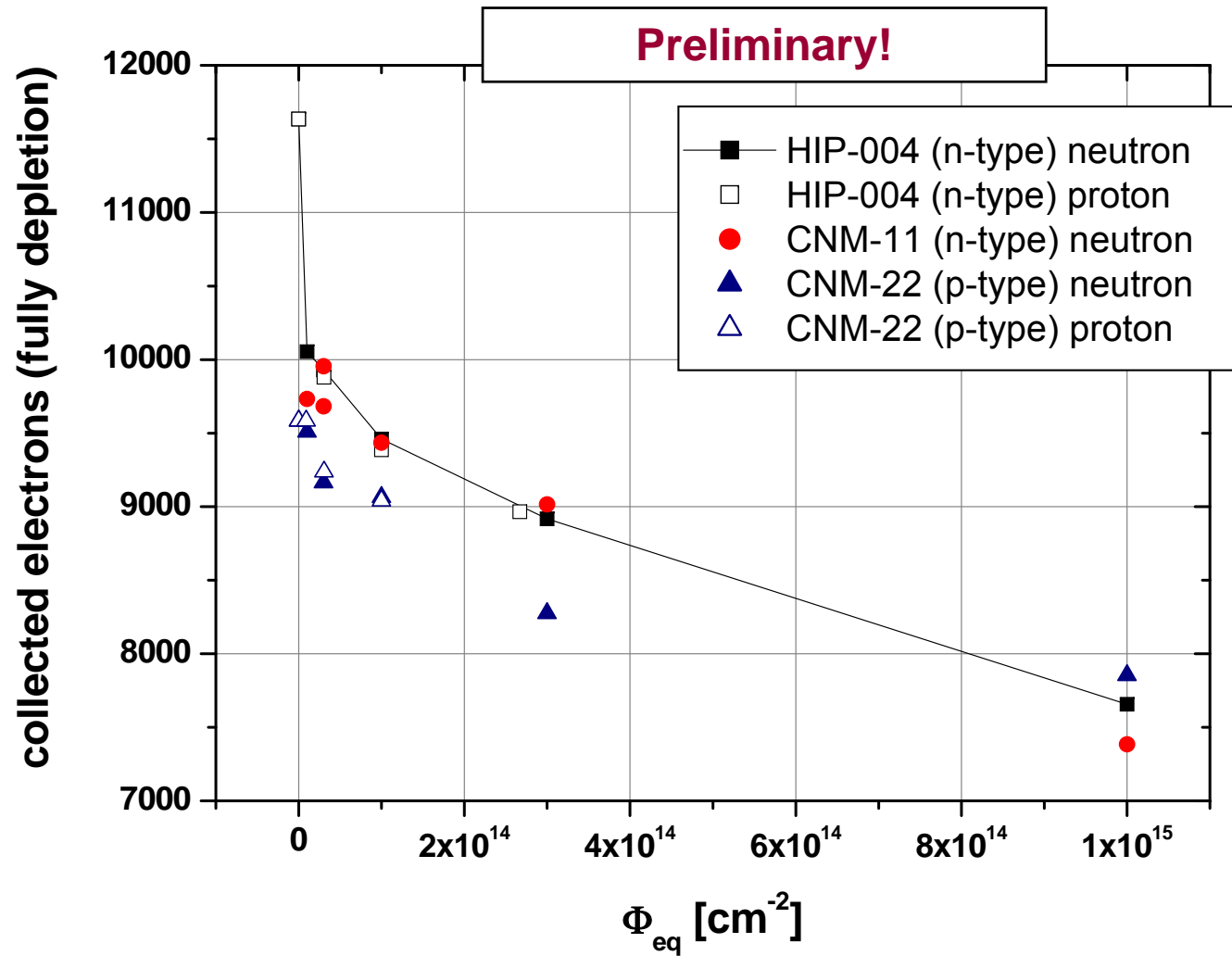
- Different detectors, same fluence
- Temperature and humidity were approximately the same
- 3-4 % difference over depletion

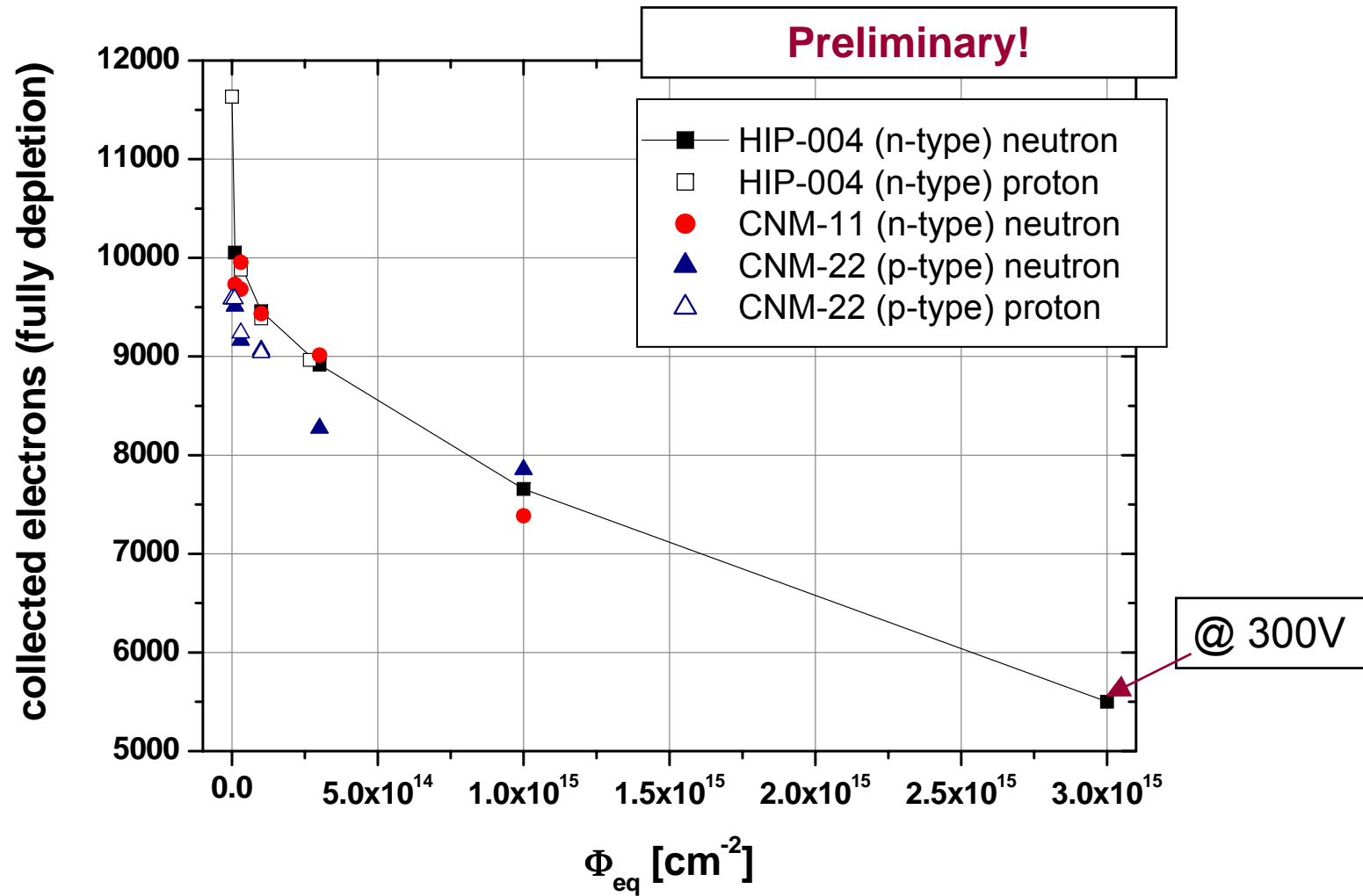


- The same detector was first measured fixed to the board with **carbon adhesive tabs**, then removed from the board and fixed with **silver glue**.
- The environmental conditions were approximately the same for both measurements (- 21°C, 20%).
- 8-10% difference over depletion
- We didn't investigate the problem further (CV, IV...) and abandoned the carbon adhesive tabs.











Summary

- Increase of depletion voltage different for different manufacturers
- Increase of depletion voltage faster for proton irradiation
- Unusual drop in CCE at low fluences, for both neutron and proton irradiation

Outlook

- Finish the measurements for the proton irradiated series and add a few more fluence points between 5×10^{14} p/cm² and 3×10^{15} p/cm²
- A set of detectors was already irradiated with protons at fluences between 1×10^{12} p/cm² and 1×10^{13} p/cm² to investigate the drop in the CCE further

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Carbon adhesive tabs



Cat. # 77827-12 100/pk
ULTRA SMOOTH CARBON
ADHESIVE TABS, 12 mm Diameter
Electron Microscopy Sciences
P.O. Box 550, 1560 Industry Road, Hatfield, PA. 19440
Phone: 215-412-8400 Fax: 215-412-8450
EMail: SGKCCK@aol.com Web: www.emsdiasum.com